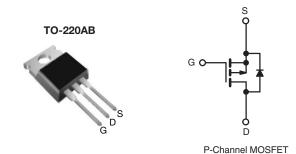


### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	- 200			
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = - 10 V 1.5			
Q <sub>g</sub> (Max.) (nC)	22			
Q <sub>gs</sub> (nC)	12			
Q <sub>gd</sub> (nC)	10			
Configuration	Single			



### **FEATURES**

- Dynamic dV/dt Rating
- P-Channel
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF9620PbF		
Lead (FD)-life	SiHF9620-E3		
SnPb	IRF9620		
SIFD	SiHF9620		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	- 200		
Gate-Source Voltage			$V_{GS}$	± 20	V	
Continuous Dunin Comment	V <sub>GS</sub> at - 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	- 3.5	А	
Continuous Drain Current		T <sub>C</sub> = 100 °C		- 2.0		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	- 14		
Linear Derating Factor				0.32	W/°C	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		P <sub>D</sub>	40	W	
Peak Diode Recovery dV/dt <sup>b</sup>			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature)	for 10 s			300°	°C	
Manustina Tanana	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $I_{SD} \le$  3.5 A,  $dI/dt \le$  95 A/µs,  $V_{DD} \le V_{DS}, T_J \le$  150 °C.
- c. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	3.1		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		<u>.</u>					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA		- 200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = - 1 mA	-	- 0.22	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = '	V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	\	/ <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zava Cata Valtaga Dvain Cuwant		V <sub>DS</sub> = -	- 200 V, V <sub>GS</sub> = 0 V	-	-	- 100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 160 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	- 500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 1.5 A <sup>b</sup>	-	-	1.5	Ω
Forward Transconductance	9fs	V <sub>DS</sub> = -	50 V, I <sub>D</sub> = - 1.5 A <sup>b</sup>	1.0	-	-	S
Dynamic		<u>.</u>					
Input Capacitance	C <sub>iss</sub>		V 0 V	-	350	-	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	100	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0			30	-	
Total Gate Charge	Qg			-	-	22	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = - 10 V	$I_D = -4.0 \text{ A}, V_{DS} = -160 \text{ V},$ see fig. 11 and 18 <sup>b</sup>	-	-	12	nC
Gate-Drain Charge	Q <sub>gd</sub>	1	See lig. 11 dild 10	-	-	10	
Turn-On Delay Time	t <sub>d(on)</sub>			-	15	-	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 100 V, $I_{D}$ = - 1.5 A, $R_{g}$ = 50 Ω, $R_{D}$ = 67 Ω, see fig. 17 <sup>b</sup>		-	25	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	20	-	
Fall Time	t <sub>f</sub>			-	15	-	
Internal Drain Inductance	L <sub>D</sub>	, ,	6 mm (0.25") from		4.5	-	-11
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s					,	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 3.5	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 14	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = - 3.5 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	- 7.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 25 °C l -	T 05 00 1 0 5 A 41/41 400 A / b		300	450	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = -3.5  \text{A},  \text{dI/dt} = 100  \text{A/} \mu \text{s}^{\text{b}}$		-	1.9	2.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tur	n-on time is negligible (turn	-on is do	minated b	y L <sub>S</sub> and	L <sub>D</sub> )

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

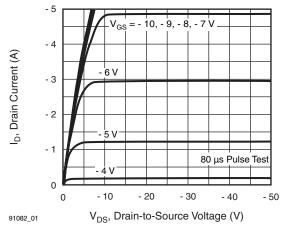


Fig. 1 - Typical Output Characteristics

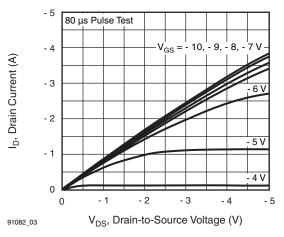


Fig. 3 - Typical Saturation Characteristics

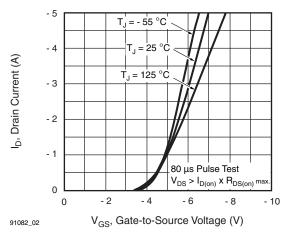


Fig. 2 - Typical Transfer Characteristics

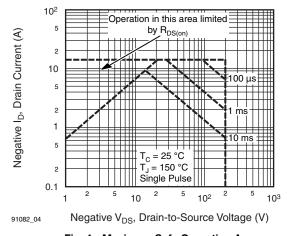


Fig. 4 - Maximum Safe Operating Area

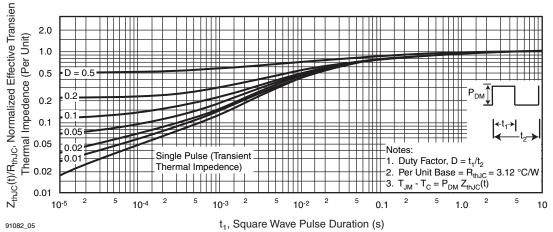


Fig. 5 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration



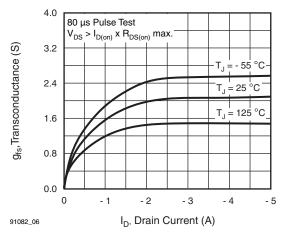


Fig. 6 - Typical Transconductance vs. Drain Current

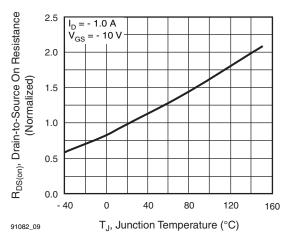


Fig. 9 - Normalized On-Resistance vs. Temperature

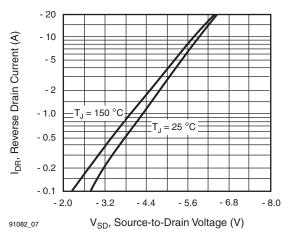


Fig. 7 - Typical Source-Drain Diode Forward Voltage

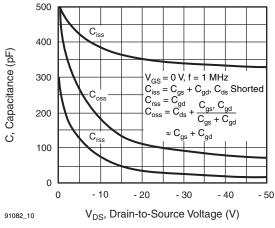


Fig. 10 - Typical Capacitance vs. Drain-to-Source Voltage

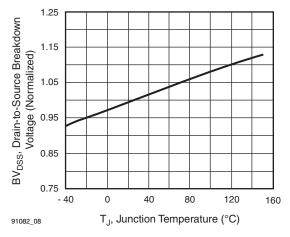


Fig. 8 - Breakdown Voltage vs. Temperature

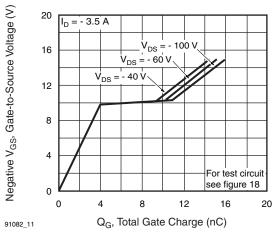


Fig. 11 - Typical Gate Charge vs. Gate-to-Source Voltage



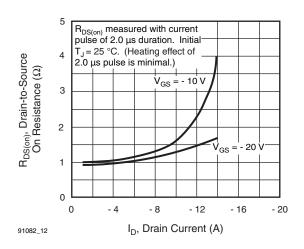


Fig. 12 - Typical On-Resistance vs. Drain Current

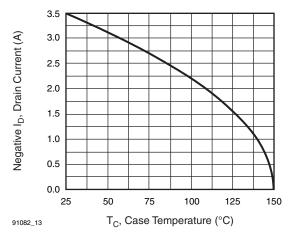


Fig. 13 - Maximum Drain Current vs. Case Temperature

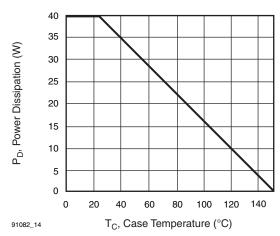


Fig. 14 - Power vs. Temperature Derating Curve

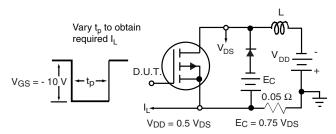


Fig. 15 - Clamped Inductive Test Circuit

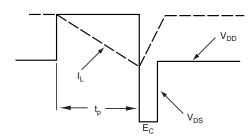


Fig. 16 - Clamped Inductive Waveforms

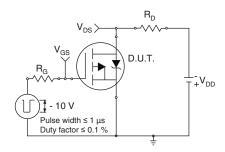


Fig. 17a - Switching Time Test Circuit

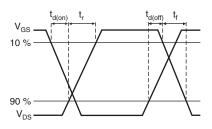


Fig. 17b - Switching Time Waveforms



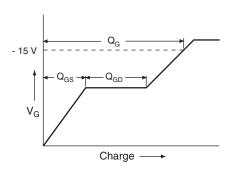


Fig. 18a - Basic Gate Charge Waveform

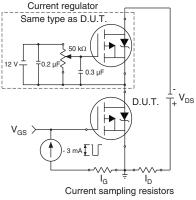
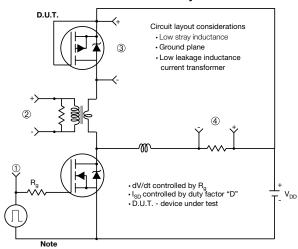


Fig. 18b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



Compliment N-Channel of D.U.T. for driver

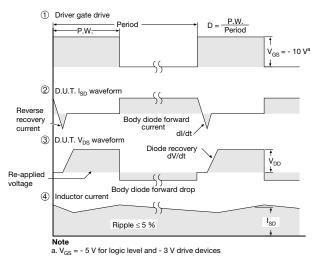


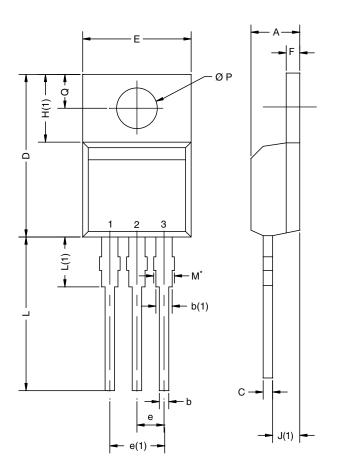
Fig. 19 - For P-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91082.





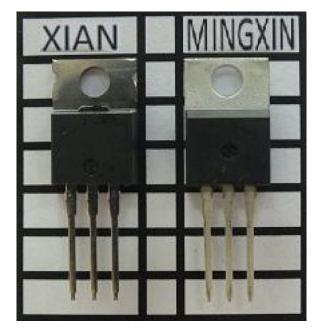
# **TO-220AB**



	MILLIN	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	

### Notes

- $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM
- · Xi'an and Mingxin actual photo





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Vishay

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